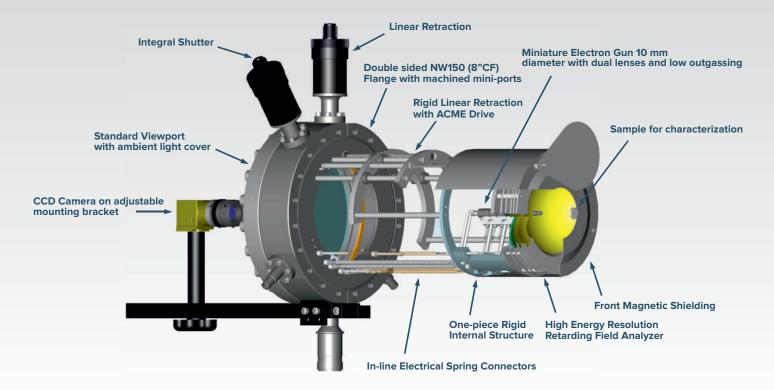
Surface Crystallography Spectrometer - IntegraLEED

based on Low Energy Electron Diffraction (LEED) and Auger Electron Spectroscopy (AES)

MODEL LEED 800 (BDL800IR) with Integral Retraction and Shutter



Features:

- High angular & energy resolution LEED & AES
- Miniature Electron Gun with double focusing
- Superior magnetic shielding
- Moiré pattern reduction
- Suitable for "in situ" epitaxial growth
- Integral Linear Motion and Shutter
- Low Outgassing Rate
- Easy add-on AES

Applications

Full size and high performance characterization tool for surface crystallography of single crystals and "in-situ" epitaxy.

The LEED 800 is capable of providing LEED and AES data for a wide range of samples.

The larger instrument size allows for higher angular and energy resolution.

Materials suitable for characterization should be single crystals and epitaxial films in categories such as: 2D materials, semiconductors, metals, oxides and magnetic films.



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IntegraLEED - MODEL LEED 800

Specifications

LEED-AUGER OPTICS (Model BDL800IR)

| Retarding Field Analyze | Concentric assembly of hemispherical grids |
|-------------------------|---|
| | Working distance from sample 18 mm |
| Grid Material | Gold coated tungsten wire mesh |
| | (100 mesh, 81% transparency) |
| Energy Resolution | 0.2% - 0.5% at low modulation volt. |
| Glass-Display | Fused silica glass coated with indium-tin oxide |
| | conductive layer and P31 phosphor |
| | (ZnS:Ag:Cu-green, 525 nm wavelength) |
| | 100° angle of acceptance from sample at a |
| | distance of 75 mm |
| Monitoring | Standard viewport on NW150 (8" CF) Flange |
| Linear Motion | Up to 150 mm retraction from sample (100 mm |
| | standard); linear ball bearing and acme thread with all |
| | spring electrical connections |
| Integral Shutter | Open and close at any position of the linear motion |
| Magnetic Shielding | Mu-metal cylinder with front cover for maximum |
| | magnetic field attenuation |
| Assembly | Extreme-high-vacuum compatibility with stainless steel, |
| | high alumina and gold-plated copper alloy materials |
| Mounting | 8"(DN150CF) double sided conflat flange with |
| | port length range 145 mm - 500 mm |
| Bakeability | Under vacuum, 250°C maximum |
| | |

Integral Miniature Electron Gun

| Beam Energy | LEED 5 eV to 750 eV |
|-----------------|---|
| | AES 5 eV to 3000 eV |
| Beam Current | LEED 2 μA at 100 eV and 0.5 mm beam size |
| | AES up to 100 µA at 3 keV |
| Beam Size | from 1 mm to 250 µm - adjusted by wehnelt voltage |
| Electron Source | Tungsten-2%Thoriated filament standard, |
| | single crystal LaB6 filament optional |
| Energy Spread | 0.45 eV (thoriated-tungsten filament) |
| Overall Size | 10 mm lens diameter and 80 mm length |

Ordering Guide

LEED Application:

| BDL800IR | LEED optics with integral electron gun on 8" flange - 3 Grids | |
|----------|--|----|
| LMX | Linear motion (X=retraction distance) | S |
| ISH | Integral shutter | |
| LPS075-D | Digital power supply with voltage range 0 - 750 V | |
| LIM12 | LEED imaging software with CCD camera, full version (optional) | |
| LIM12B | LEED imaging software with CCD camera, basic version (optiona | I) |

LEED and AES Application:

| BDL800IR | LEED optics with integral electron gun on 8" flange - 4 Grids |
|-----------|---|
| LMX | Linear motion (X=retraction distance) |
| ISH | Integral shutter |
| LPS300-D | Digital power supply with voltage range 0 - 3 kV |
| LOA10-AES | Digital AES controller with ramp voltage, sinewave oscillator, |
| | lock-in and AES software |
| LIM12 | LEED imaging software with CCD camera, full version (optional) |
| LIM12B | LEED imaging software with CCD camera, basic version (optional) |
| | |

Control Electronics

LPS075-D Digital LEED

Power supply (0-750 V) with USB interface and PC control software for Windows 10. True primary beam current and total emission measurements. Automatic start-up and shut down, 10 memory settings including standby and outgassing mode with timer, constant beam current mode.

LPS300-D Digital LEED-AES

Power supply (0-3.2 kV) with USB interface and PC control software for Windows 10. True primary beam current and total emission measurements. Automatic start-up and shut down, 10 memory settings including outgassing with timer, automatic switch from LEED to AES, constant beam current mode.

LOA10-AES

Digital AES controller with lock-in amplifier, AES high voltage ramp board 0-2.0 kV with precision sinewave oscillator (0.5-20 Vpk-pk) and AES software for Windows 10. USB communication to PC.

LEED Software

LIM12B

Basic LEED pattern measurements and analysis software and hardware for Windows 10 including:

- Automatic LEED pattern acquisition
- CCD camera
- Flange Mounting kit with ambient light cover and cables

LIM12

Full version LEED pattern measurements and analysis software and hardware for Windows 10 including:

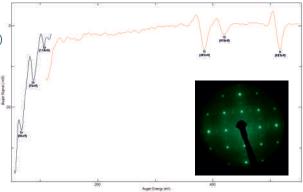
- CCD camera
- Flange mounting kit with ambient light cover and cables
- Software features:
 - o Automatic LEED pattern acquisition
 - o Automatic I-V analysis with spot tracking
 - o Automatic I-T analysis
 - o Automatic spot profile analysis

CCD Camera Specifications

- 12-bit colour high performance video CCD camera with sensitivity control and USB3.1 interface
- 1/3" CCD sensor size, image size: 1.3 MP (1288x964), 3.75 um pixel size, CS-mount lenses
- Linear Full Well: 9000e-, Dynamic Range: 59 dB

Data

LEED pattern and AES spectrum SrTiO3 (100) - single crystal wafer after thermal annealing at 850°C in UHV

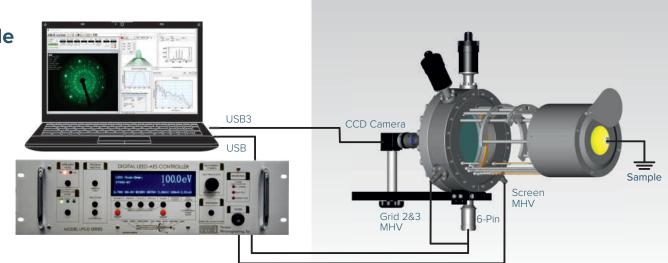


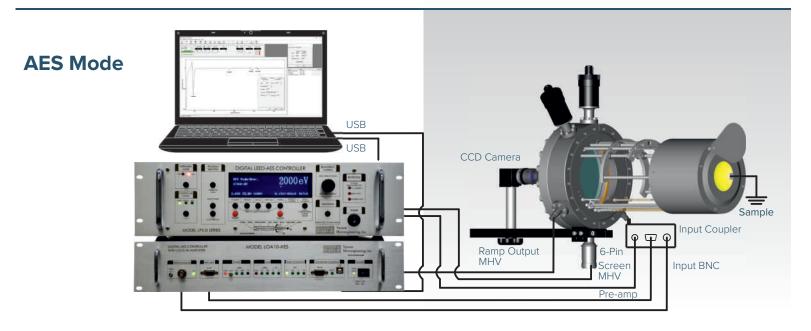
Link for more data: http://www.ocivm.com/leed-aes-data.html

IntegraLEED - MODEL LEED 800

Connection Diagrams

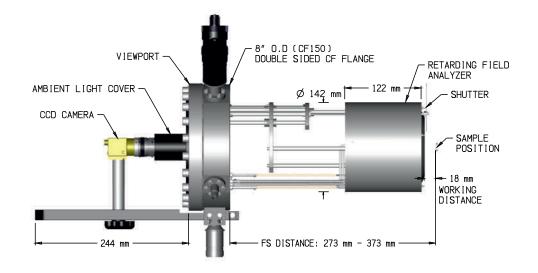
LEED Mode





Schematic Drawings

BDL800IR-LMX-ISH SIDE VIEW WITH 100mm RETRACTION



IntegraLEED - MODEL LEED 800

LEED Optics and UHV Chamber Configuration

Calculation formula for Flange-Sample distance and Retraction length:

FS = 173 mm + 2 LMX - OV

FS - flange to sample distance **LMX** - retraction length **OV** - overlapping length PL - port length NL - nipple length

